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Docket Number (Optional) LEE.002	Application Number NEW		
Applicant(s) Shone FUJA			
Filing Date	Group Art Unit		
January 5, 2004	To Be Assigned		

U.S.	PATENT	DOCE	MENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING D	
D Y	A	5,739,567	04/14/1998	WONG				
	В	5,770,514	06/23/1998	MATSUDA et al.				
	С	6,544,824	04/08/2003	PRADEEP et al.				•
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	REF	DOCUMENT NUMBER			CLASS	SUBCLASS	Translation	
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		ID Monthly and I II	- 0/5-1-11-1		Author, Title, D			
b٧		embedded Memory Ce	nter, 2003 IEEE,	Onm Silicon Nanocrystal Nonvolatii 4 pgs.	e Memory", D	igitaiDNA Lac	ooratories an	a ta
	1	B. De Salvo et al. "Hoy	v far will Silicon r	nanocrystals push the scaling limits o	f NVMs techn	ologies?", 2003	3 IEEE, 4 pg	s.
DV		F						

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.